60V, 13A, 9.4mΩ N-channel Power SGT MOSFET

JMSL0608PP

Features

- $\bullet \;\;$ Excellent $R_{DS(ON)}$ and Low Gate Charge
- 100% UIS TESTED
- 100% ΔVds TESTED
- Halogen-free; RoHS-compliant
- Pb-free plating

Applications

- Load Switch
- PWM Application
- Power Management

Product Summary

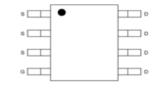
Parameters	Value	Unit
V_{DSS}	60	V
$V_{GS(th)_Typ}$	1.7	V
I _D (@V _{GS} =10V)	14	Α
$R_{DS(ON)_Typ}(@V_{GS}=10V$	7.9	mΩ
$R_{DS(ON)_Typ}(@V_{GS}=4.5V$	9.4	mΩ

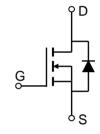












SOP-8

Pin Assignment

Schematic Diagram

Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSL0608PP	SL0608P	3	Tape&Reel	SOP-8	4000	40000

Absolute Maximum Ratings (@ T_A = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit
V_{DS}	Drain-to-Source Voltage		60	V
V_{GS}	Gate-to-Source Voltage		±20	V
	Continuous Drain Current	$T_A = 25$ °C	14	Λ
I _D	Continuous Drain Current	$T_A = 100$ °C	10	- A
I_{DM}	Pulsed Drain Current (1)		Refer to Fig.4	Α
E _{AS}	Single Pulsed Avalanche Energy (2)		74	mJ
P _D		$T_A = 25$ °C	2.8	W
		$T_A = 100$ °C	1	
T_{J}, T_{STG}	Junction & Storage Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	65	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (4)	45	C/VV



Electrical Characteristics (T_J = 25°C unless otherwise specified)

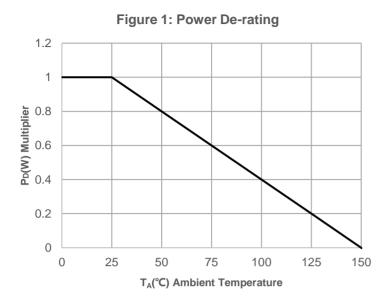
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	nracteristics			,		,
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 48V, V_{GS} = 0V$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics			•		
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2	1.7	2.3	V
D	(5)	$V_{GS} = 10V, I_D = 12A$	-	7.9	10.3	mΩ
$R_{DS(ON)}$	Static Drain-Source ON-Resistance ⁽⁵⁾	$V_{GS} = 4.5V, I_D = 6A$	-	9.4	12.2	mΩ
Dynami	ic Characteristics					
R_g	Gate Resistance	f = 1MHz	-	2	-	Ω
C _{iss}	Input Capacitance		-	1178	-	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 30V,$ $f = 1MHz$	-	513	-	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/2	-	34	-	pF
Qg	Total Gate Charge	V 0. 45V	-	21	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 4.5V$ $V_{DS} = 30V, I_{D} = 15A$	-	4	-	nC
Q_{gd}	Gate Drain("Miller") Charge		-	5	-	nC
					•	
Switchi	ng Characteristics			T	ı	1
$t_{d(on)}$	Turn-On DelayTime	_	-	7	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 30V$	-	24	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	I_D = 15A, R_{GEN} = 3Ω	-	22	-	ns
t _f	Turn-Off Fall Time		-	6	-	ns
Body D	iode Characteristics					
I _S	Maximum Continuous Body Diode Forward Current		-	-	14	Α
I_{SM}	Maximum Pulsed Body Diode Forward Cur	rent	-	-	56	А
V _{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 12A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	1 1EA di/d+ 100A/	-	32	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 15A$, di/dt = 100A/us	-	23.6	-	nC

Notes:

- ${\bf 1.}\ {\bf Repetitive}\ {\bf Rating:}\ {\bf Pulse}\ {\bf Width}\ {\bf Limited}\ {\bf by}\ {\bf Maximum}\ {\bf Junction}\ {\bf Temperature}.$
- 2. E_{AS} condition: Starting T_J =25C, V_{DD} =30V, V_G =10V, R_G =25ohm, L=3mH, I_{AS} =7A, V_{DD} =0V during time in avalanche.
- 3. $R_{\theta JA}$ is measured with the device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
- 4. $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.
- 5. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.



Typical Performance Characteristics



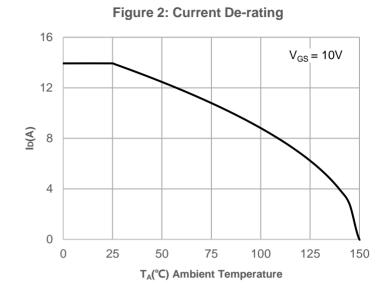
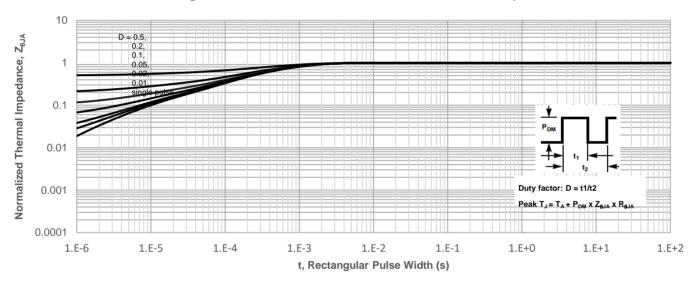
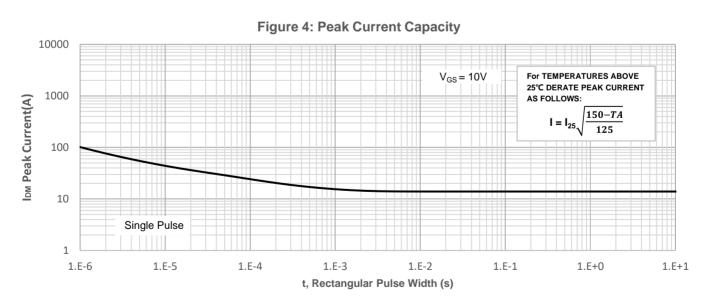


Figure 3: Normalized Maximum Transient Thermal Impedance







Typical Performance Characteristics

Figure 5: Output Characteristics

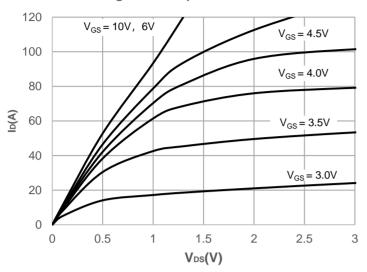


Figure 6: Typical Transfer Characteristics

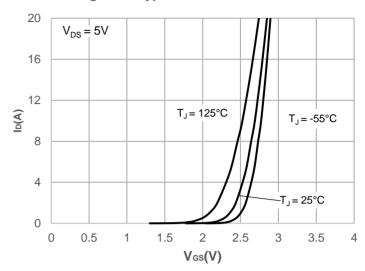


Figure 7: On-resistance vs. Drain Current

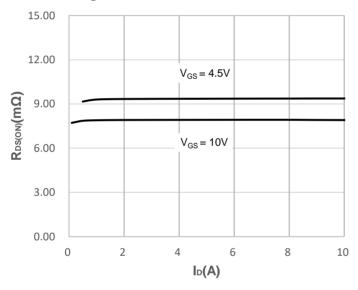


Figure 8: Body Diode Characteristics

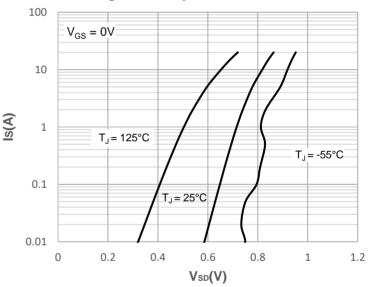


Figure 9: Gate Charge Characteristics

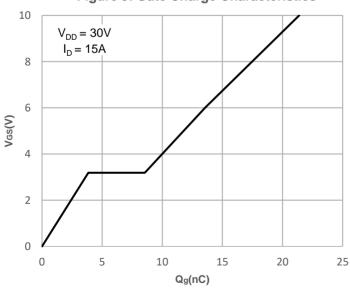
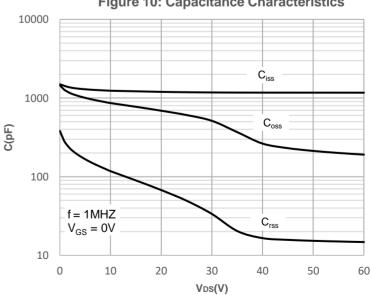


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

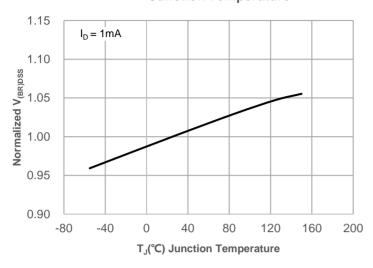


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

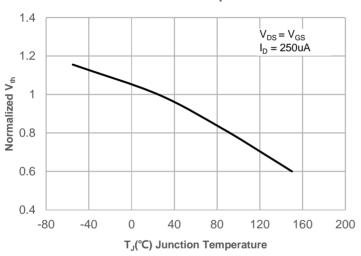


Figure 15: Maximum Safe Operating Area

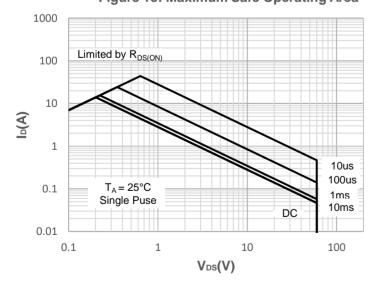


Figure 12: Normalized on Resistance vs. Junction Temperature

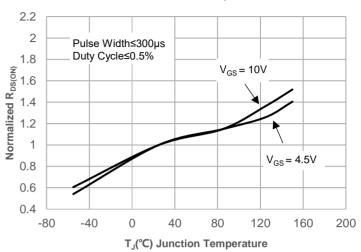
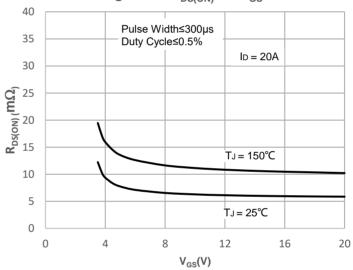


Figure 14: R_{DS(ON)} vs. V_{GS}





Test Circuit

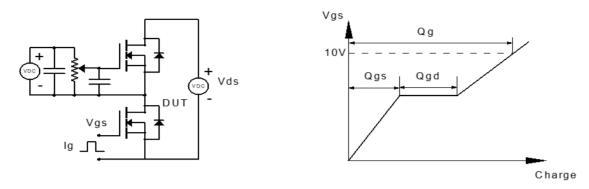


Figure 1: Gate Charge Test Circuit & Waveform

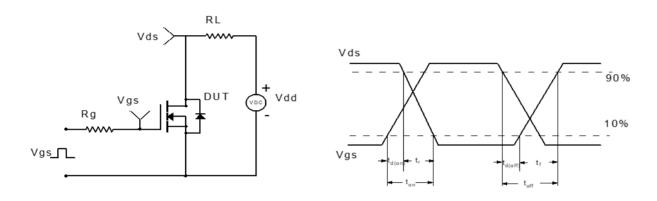


Figure 2: Resistive Switching Test Circuit & Waveform

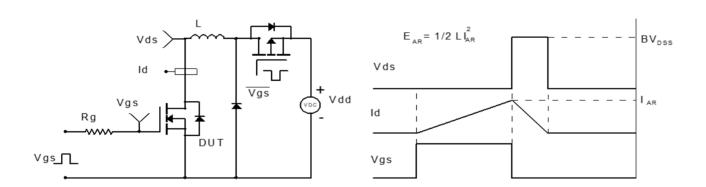


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

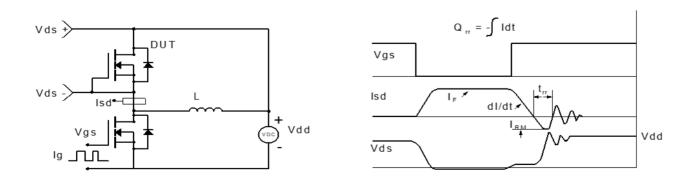
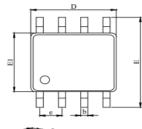


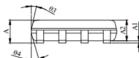
Figure 4: Diode Recovery Test Circuit & Waveform

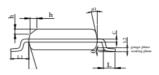


Package Mechanical Data(SOP-8)

Package Outline

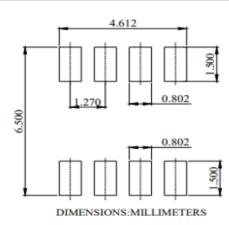






DIM	MILLIMETER			
DIM	MIN.	NOM.	MAX.	
A	1.35	1.50	1.65	
A1	0.05	0.10	0.15	
A2	1.35	1.40	1.50	
ь	0.38		0.50	
с	0.17		0.25	
D	4.80	4.90	5.00	
Е	5.80	6.00	6.20	
El	3.80	3.90	4.00	
e	1.27(BSC)			
L	0.45	0.60	0.80	
Ll	1.04 REF			
L2	0.25 BSC			
h	0.30	0.40	0.50	
θ	0°		8°	
θ1	10°	12°	14°	
θ2	8°	10°	12°	
θ3	10°	12°	14°	
θ4	8°	10°	12°	

Recommended Footprint



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